

Sequential design of experiments on a stochastic multi-fidelity simulator

STROH Rémi^(a,b) BECT Julien^(a), VAZQUEZ Emmanuel^(a) DEMEYER Séverine^(b), FISCHER Nicolas^(b) (a) Laboratoire des Signaux et Systèmes (L2S) aboratoire National de métrologie et d'Essais (LNE)

MEASUREMENT AND STANDARDS

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COMPETITIVENESS AND SAFETY VECTOR

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Outline

2. Sequential design of experiments

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3. Academic example





Outline

2. Sequential design of experiments

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3. Academic example



- Fire safety: conformity of a smoke extraction system
 - Expensive experiments → use of numerical models





Fire Dynamics Simulator (FDS)

Real Experiment

• Images from [Kerber, 2005]



Context

Properties of numerical models



- Main properties of the considered simulators:
 - 1. Multi-fidelity
 - 2. Tunable cost
 - 3. Stochastic outputs



$$(x,t) \longrightarrow$$
Simulator $\longrightarrow Z$

Multi-fidelity: same physical phenomenon
 Several models with various accuracy





Multi-fidelity

$$(x,t) \longrightarrow$$
Simulator $\longrightarrow Z$

- Cost of observation: function of the fidelity C(t)
 - Cheap simulation, but low fidelity

Tunable cost

High fidelity simulation, but time-consuming





$$(x,t) \longrightarrow$$
 Simulator $\longrightarrow Z \sim \mathbb{P}_{x,t}^{sim}$

• Stochastic: same input \rightarrow different outputs





$$(x,t) \longrightarrow$$
 Simulator $\longrightarrow Z \longrightarrow \mathbb{P}_{x,t^{HF}}^{sim}(Z > z^{crit})$

- Probability of exceeding a critical threshold z^{crit} $p(x, t^{HF}) = \mathbb{P}_{x,t^{HF}}^{sim}(Z > z^{crit})$
 - t^{HF} : the highest-fidelity level





- <u>Goal</u>: selecting $(x_1, t_1), \dots, (x_n, t_n)$ to estimate the function p with a minimal cost $C(t_1) + \dots + C(t_n)$
 - Observations $(x_i, t_i; z_i)_{1 \le i \le n}$ \rightarrow Estimation \hat{p}_n of p





- <u>Goal</u>: selecting $(x_1, t_1), ..., (x_n, t_n)$ to estimate the function p with a minimal cost $C(t_1) + \cdots + C(t_n)$
- Sequential design
 - use the *n* first observations to select the $(n + 1)^{th}$ observation



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- Prior distribution:
 - Output *Z* at *x*, *t* follows a normal distribution $Z|\xi \sim \mathcal{N}(\xi(x,t),\lambda(x,t))$
 - Mean function ξ : Gaussian process $\xi \sim \mathcal{GP}(m, k)$
- Posterior distribution: kriging
 - Mean function $\xi | \chi_n$

 $\xi|\chi_n \sim \mathcal{GP}(m_n, k_n)$



Mean function

$$\xi(x,t) = \begin{cases} \xi_{LF}(x) & \text{if } t = 1\\ \rho \xi_{LF}(x) + \delta(x) & \text{if } t = 2 \end{cases}$$

- ξ_{LF} : low-fidelity simulator
- $\xi_{HF} = \rho \xi_{LF} + \delta$: high-fidelity simulator, linked to the low-fidelity by a linear relationship

→ Covariance function

$$k((x,t),(x',t')) = \begin{cases} k_{LF}(x,x') & \text{if } t = t' = 1\\ \rho k_{LF}(x,x') & \text{if } t \neq t'\\ \rho^2 k_{LF}(x,x') + k_{\delta}(x,x') & \text{if } t = t' = 2 \end{cases}$$

- k_{LF} : covariance of the low-fidelity simulator
- k_{δ} : covariance of the difference between high- and low-fidelity levels
- ρ : correlation between the low- and high-fidelity levels



Mean function

$$\xi(x,t) = \xi_0(x) + \epsilon(x,t)$$

- ξ_0 : ideal simulator (Ex: mesh size = 0)
- ϵ : system error between ideal and real simulators at t

→ Covariance function

$$k((x,t),(x',t')) = k_0(x,x') + r(t,t') \cdot k_{\epsilon}(x,x')$$

- k_0 : covariance of ξ_0
- k_{ϵ} : covariance of ϵ according to x
- r: rules the decrease of the error
- [Picheny and Ginsbourger, 2013], [Tuo et al., 2014]



• Probability of exceeding the critical threshold:

$$p(x,t) = \mathbb{P}_{x,t}^{sim} \left(Z > z^{crit} | \chi_n \right) = \Phi \left(\frac{\xi(x,t) - z^{crit}}{\sqrt{\lambda(x,t)}} \right)$$

- First and second moments
 - Expectation: $\mathbb{E}_n[p(x,t)] = \Phi(u_n(x,t)) = \hat{p}_n(x,t)$ Variance: $\mathbb{V}ar_n[p(x,t)] = \Phi_2(u_n(x,t), u_n(x,t); r_n(x,t)) - \Phi^2(u_n(x,t))$
 - $u_n(x,t) = \frac{m_n(x,t) z^{crit}}{\sqrt{\sigma_n^2(x,t) + \lambda(x,t)}}$ $r_n(x,t) = \frac{\sigma_n^2(x,t)}{\sigma_n^2(x,t) + \lambda(x,t)}$
 - $\bullet \quad \sigma_n^2(x,t) = k_n\bigl((x,t),(x,t)\bigr)$
 - Φ : cumulative distribution function (cdf) of the normal distribution Φ_2 : cdf of the bivariate normal distribution



Measure of uncertainty

• Measure of uncertainty

$$H_n = \mathbb{E}_n[\|\hat{p}_n(\cdot, t^{HF}) - p(\cdot, t^{HF})\|^2] = \int_{\mathbb{X}} \mathbb{V}ar_n[p(x, t^{HF})]dx$$

• \mathbb{L}^2 -norm of the error of the estimator at the highest level of fidelity



Stepwise Uncertainty Reduction

• Measure of uncertainty

$$H_n = \mathbb{E}_n[\|\hat{p}_n(\cdot, t^{HF}) - p(\cdot, t^{HF})\|^2] = \int_{\mathbb{X}} \mathbb{V}ar_n[p(x, t^{HF})]dx$$

- Stepwise uncertainty reduction algorithm $(x_{n+1}, t_{n+1}) = \underset{x,t}{\operatorname{argmin}} \{ \mathbb{E}_n[H_{n+1}|X_{n+1} = x, T_{n+1} = t] \}$
- [Vazquez and Bect, 2009]



Stepwise Uncertainty Reduction

• Measure of uncertainty

$$H_n = \mathbb{E}_n[\|\hat{p}_n(\cdot, t^{HF}) - p(\cdot, t^{HF})\|^2] = \int_{\mathbb{X}} \mathbb{V}ar_n[p(x, t^{HF})]dx$$

- Stepwise uncertainty reduction algorithm $(x_{n+1}, t_{n+1}) = \underset{x,t}{\operatorname{argmin}} \{ \mathbb{E}_n[H_{n+1} | X_{n+1} = x, T_{n+1} = t] \}$
- Analytical expression $\mathbb{E}_{n}[H_{n+1}|X_{n+1} = x, T_{n+1} = t]$ $= \int_{\mathbb{X}} \left[\Phi_{2}(u_{n}(y, t^{HF}), u_{n}(y, t^{HF}); r_{n}(y, t^{HF})) - \Phi_{2}(u_{n}(y, t^{HF}), u_{n}(y, t^{HF}); \widetilde{r_{n}}((x, t), (y, t^{HF}))) \right] dy$
 - $\widetilde{r_n}((x,t),(y,t^{HF})) = \frac{k((x,t),(y,t^{HF}))^2}{(\sigma_n^2(x,t)+\lambda(x,t))\cdot(\sigma_n^2(y,t^{HF})+\lambda(y,t^{HF}))}$



- Different costs C(x, t) of observations
 → Trade-off between H_n reduction and cost C(x, t)
- [Huang et al. 2006], [Le Gratiet and Cannamela, 2015]: comparison between benefit and cost



- Maximum Speed of Uncertainty Reduction (MSUR) $(x_{n+1}, t_{n+1}) = \operatorname*{argmax}_{x,t} \left\{ \frac{H_n - \mathbb{E}_n[H_{n+1}|X_{n+1} = x, T_{n+1} = t]}{C(x, t)} \right\}$
 - MSUR = Benefit/Cost
 - Adaptable for any measure of uncertainty H_n
 - If C is constant \rightarrow equivalent to SUR algorithm





→ Algorithm: separate optimization of the point x and the level t

1.
$$x^{*}(t) = \underset{x}{\operatorname{argmin}} \{ \mathbb{E}_{n}[H_{n+1}|X_{n+1} = x, T_{n+1} = t] \}$$

2. $t_{n+1} = \underset{t}{\operatorname{argmax}} \{ \frac{H_{n} - \mathbb{E}_{n}[H_{n+1}|X_{n+1} = x^{*}(t), T_{n+1} = t]}{C(t)} \}$
3. $x_{n+1} = x^{*}(t_{n+1})$



Simplification

1. Introduction

2. Sequential design of experiments

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3. Academic example



1. Introduction

2. Sequential design of experiments

- 3. Academic example
 - a. Presentation of the example
 - b. Comparison of sequential designs of experiments



Stochastic damped harmonic oscillator

- Consider a damped harmonic simulator with random drive $\ddot{X}(t) + 2\zeta \omega_0 \dot{X}(t) + \omega_0^2 X(t) = W(t)$
 - ω_0 : the undamped angular frequency
 - ζ : the damping ratio
 - *W*: a Brownian motion, with spectral density S = 1
 - Initial conditions: X(t = 0) = 0, $\dot{X}(t = 0) = 0$



- Consider a damped harmonic simulator with random drive $\ddot{X}(t) + 2\zeta \omega_0 \dot{X}(t) + \omega_0^2 X(t) = W(t)$
- Ideal simulator $F: (\omega_0, \zeta) \mapsto \max_{0 \le t \le t^{\text{end}} = 30} \{ \log |X(t)| \}$ $ω_0 = 15.708 \text{ rad/s}; \zeta = 0.2$ $ω_0 = 15.708 \text{ rad/s}; \zeta = 0.2;$ 0 Γ 0.15 0.1 0.05 log |X(t)| X(t) $\log(|\cdot|)$ -0.03 -0.1 -14 -0.15 -16 L 0 0 20 25 30 10 15 20 25 10 15 5 5 t t



Simulator

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- Approximation by an *explicit Exponential Euler Scheme* $X(n \cdot dt) \approx \tilde{X}_n$
- Multi-fidelity simulator

$$f: (\omega_0, \zeta, dt) \mapsto \max_{0 \le n \le \left\lfloor \frac{t^{\text{end}}}{dt} \right\rfloor} \{ \log |\tilde{X}_n| \}$$





Output distributions at a fixed input

- The output distribution at (ω₀, ζ, dt) can be approximated by a normal distribution
 - 10^5 simulations at $\omega_0 = 15.708$ rad/s and $\zeta = 0.2$





Mean function

- Mean function ξ
 - 10⁵ simulations
 - $0 \le \omega_0 \le 30 \text{ rad/s}, \ 0 \le \zeta \le 1 \text{ Grid}: 100 \times 100$





• Critical threshold $z^{crit} = -3$

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Threshold



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Probability of exceeding the threshold

• True probability of exceeding the threshold $p(\omega_0, \zeta; dt)$





Computation time

• Computation time C(dt) : linear in 1/dt.

Time step <i>dt</i>	1 s	0.2 s	0.05 s	0.01 s
CPU Time (ms)	0.799 ms	1.85 ms	5.78 ms	26.7 ms
Cost function $C(dt)$	0.030 ¤	0.069 ¤	0.217 ¤	1.00 ¤





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- Target: probability of exceeding the threshold at the highest level of fidelity dt = 0.01 s
- Initial design: Nested LHS on 5 levels

<i>dt</i> (s)	1.00	0.50	0.33	0.25	0.20	0.17	0.10	0.05	0.02	0.01
Nb. points	180	60	20	10	5	0	0	0	0	0

• [Qian, 2009]

- Initial budget: 9.87 ¤
 - 1 = cost for 1 observation at the level dt = 0.01 s
 - = cost for 1.96 observations at the level dt = 0.02 s
 - = cost for 33.4 observations at the level dt = 1 s



- Initial budget: 9.87 ¤
 Supplementary budget: 10 ¤
- 6 designs of experiments (DoE)
 - 5 Single level DoE
 - Multi-level DoE

Sequential design	Criterion	Nb. Points Initial design	Nb. Points Final design
Single level ($dt = 0.17 s$)	SUR	275	275+145 = 420
Single level ($dt = 0.10 s$)	SUR	275	275 + 85 = 360
Single level ($dt = 0.05 s$)	SUR	275	275 + 46 = 321
Single level ($dt = 0.02 s$)	SUR	275	275 + 19 = 294
Single level ($dt = 0.01 s$)	SUR	275	275 + 10 = 285
Multi-level	MSUR	275	275 + ? = ?



- Initial budget: 9.87 ¤
 Supplementary budget: 10 ¤
- 6 designs of experiments (DoE)
 - 5 Single level DoE
 - Multi-level DoE
- Same model:
 - Same covariance function
 - Hyper-parameters estimated on a large design
 - Fixed hyper-parameters during the sequential designs
- Each DoE: 12 repetitions



 \mathbb{L}^2 -error on the probability function

$$\sqrt{\int_{[0;30]\times[0;1]} (\hat{p}_n(x, t^{HF}) - p(x, t^{HF}))^2 dx} t^{HF} = 0.01 \text{ s}$$



 \mathbb{L}^2 -error on the probability function



- Low-fidelity levels are biased High-fidelity levels are slow
- In this example, multi-fidelity finds the best trade-off

- <u>Goal</u>: sequential design of experiments to estimate probability on stochastic multi-fidelity numerical models
- New SUR criteria to estimate probability of exceeding a threshold on stochastic simulator
- Adaptation to multi-fidelity model → Maximum Speed of Uncertainty Reduction (MSUR)
 - MSUR = (Uncertainty Reduction)/Cost
- Results on an academic example → automatic trade-off between cost and fidelity



Conclusion

Thank you for your attention!



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Mean and variance functions

• Mean function ξ and variance function λ





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